



**American International University- Bangladesh**  
**Faculty of Engineering (FE)**  
**Department of Electrical and Electronic Engineering (EEE)**  
**EEE 2104: Electronic Devices Lab**

**Title of the Experiment:** Study of Single-Stage Bipolar Junction Transistor (BJT)-Based Common Emitter Amplifier Circuit.

**Objectives:**

The objectives of this experiment are to

1. Trace the circuit diagram of a single-stage transistor amplifier.
2. Establish the proper DC operating point (Q-point) of a bipolar transistor-based amplifier circuit.
3. Measure the Beta ( $\beta$ ) of the transistor with a multimeter.
4. Measure the maximum signal that can be amplified with the amplifier without any distortion.
5. Measure the voltage gain of the amplifier at an input frequency of 1 kHz.
6. Measure the voltage gain of the amplifier at different values of load resistances.

**Theory:**

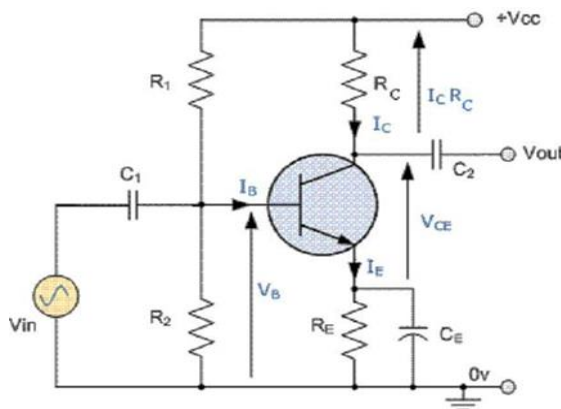
The aim of the AC analysis is to determine the Q point of a common emitter configuration which will ensure an undistorted amplification of a signal. In this regard, a DC analysis will be performed to adjust Q at a suitable location on the characteristic curve. After performing the DC analysis, the small signal parameters will be calculated depending on the model being used. Gain dependency on the load resistors will also be observed.

The most common circuit configuration for an NPN transistor is that of the Common Emitter (CE) amplifier and a family of curves known commonly as the output characteristics curves, which relate the collector current ( $I_C$ ), to the output or collector voltage ( $V_{CE}$ ), for different values of base current ( $I_B$ ). All types of transistor amplifiers operate using AC signal inputs which alternate between a positive value and a negative value. Presetting the amplifier circuit to operate between these two maximum or peak values is achieved using a process known as biasing. Biasing is very important in amplifier design as it establishes the correct operating point of the transistor amplifier ready to receive signals, thereby reducing any distortion to the output signal.

The single-stage common emitter amplifier circuit shown in Fig. 1 uses a 'Voltage Divider Biasing' circuit. The base voltage ( $V_B$ ) can be easily calculated using the simple voltage divider formula as in equation (1) from Fig. 1.

$$V_B = \frac{R_2}{R_1 + R_2} V_{CC} \quad (1)$$

Thus, the base voltage is fixed by biasing and independent of the base current provided the current in the divider circuit is large compared to the base current. Assuming  $I_B \approx 0$ , one can do the approximate analysis of the voltage divider network without using the transistor gain,  $\beta$  in the calculation. Note that the approximate approach can be applied with a high degree of accuracy when the following condition is satisfied:  $\beta R_E \geq 10R_2$ .



**Figure 1:** Circuit diagram of an npn transistor-based common emitter amplifier.

### Load Line and Q-point

A static or DC load line can be drawn onto the output characteristics curves of the transistor to show all the possible operating points of the transistor from fully ON ( $I_C = \frac{V_{CC}-V_{CE}}{R_C+R_E} \cong \frac{V_{CC}}{R_C+R_E}$ ) to fully OFF ( $I_C = 0$ ). The quiescent operating point or Q-point is a point on this load line that represents the values of  $I_C$  and  $V_{CE}$  that exist in the circuit when no input signal is applied. Knowing  $V_B$ ,  $I_C$ , and  $V_{CE}$  can be calculated to locate the operating point of the circuit as follows:

$$V_E = V_B - V_{BE}$$

So, the emitter current,  $I_{EQ} = I_{CQ} = \frac{V_{CC}-V_{CEQ}}{R_C+R_E}$  and  $V_{CEQ} = V_{CC} - I_{CQ}R_C - I_{EQ}R_E$ .

It can be noted here that the sequence of calculation does not need the knowledge of  $\beta$  and  $I_B$  is not calculated. So, the Q-point is stable against any replacement of the transistor. Since the aim of any small signal amplifier is to generate an amplified input signal at the output with the minimum distortion possible, the best position for this Q-point is as close to the center position of the load line as reasonably possible, thereby producing a Class A type amplifier operation, i.e.,  $V_{CEQ} = \frac{V_{CC}}{2}$ .

### Coupling and Bypass Capacitors

In CE amplifier circuits, capacitors  $C_1$  and  $C_2$  are used as coupling capacitors to separate the AC signals from the DC biasing voltage. The capacitors will only pass AC signals and block any DC component. Thus, they allow the coupling of the AC signal into an amplifier stage without disturbing its Q point. The output AC signal is then superimposed on the biasing of the following stages. Also, a bypass capacitor,  $C_E$  is included in the emitter terminal. This capacitor is an open circuit component for DC bias, meaning that the biasing currents and voltages are not affected by the addition of the capacitor maintaining good Q-point stability. However, this bypass capacitor acts as a short circuit path across the emitter resistor at high frequency signals increasing the voltage gain to its maximum. Generally, the value of the bypass capacitor,  $C_E$  is chosen to provide a reactance of at most,  $1/10^{\text{th}}$  the value of  $R_E$  at the lowest operating signal frequency.

### Amplifier Operation

Once the Q-point is fixed through DC bias, an AC signal is applied at the input using coupling capacitor  $C_1$ . During the positive half cycle of the signal,  $V_{BE}$  increases leading to increased  $I_B$ . Therefore,  $I_C$  increases by  $\beta$  times leading to a decrease in the output voltage,  $V_{CE}$ . Thus, the CE amplifier produces an amplified output with a phase reversal. The voltage gain of the common emitter amplifier is equal to the ratio of the change in the output voltage to the change in the input voltage. Thus, the voltage gain expression can be written as,

$$A_v = \frac{V_{out}}{V_{in}} = \frac{\Delta V_{CE}}{\Delta V_{BE}}$$

The input ( $Z_i$ ) and output ( $Z_o$ ) impedances of the circuit can be computed for the case when the emitter resistor,  $R_E$  is completely bypassed by the capacitor,  $C_E$ .

$$Z_i = R_1 \parallel R_2 \parallel \beta r_e \text{ and } Z_o = R_C \parallel r_o$$

Where,  $r_e$  ( $26\text{mV}/I_E$ ) and  $r_o$  are the emitter diode resistance and output dynamic resistance (can be determined from output characteristics of the transistor). Usually  $r_o \geq 10R_C$ , thus, the gain can be approximated as,

$$A_v = \frac{V_{out}}{V_{in}} = -\frac{I_C Z_o}{I_B Z_i} = -\frac{\beta I_B R_C \parallel r_o}{I_B \beta r_e} = -\frac{R_C}{r_e}$$

The negative sign accounts for the phase reversal at the output. In the circuit diagram, the emitter resistor is split into two to reduce the gain to avoid distortion. So, the expression for gain is modified as,

$$A_v = \frac{V_{out}}{V_{in}} = -\frac{R_C}{R_E + r_e}$$

### Biasing Issues:

We will use the most applied biasing circuit to operate the BJT as an amplifier. A single power supply is used and the **voltage divider network** consisting of two resistors at the base,  $R_{B1}$  and  $R_{B2}$  is used to adjust the base voltage. Using the Thevenin theorem, the voltage divider network may be modeled by a Thevenin equivalent circuit and is replaced by Thevenin equivalent voltage,  $V_{TH}$  and Thevenin equivalent resistance,  $R_{TH}$  where,

$$V_{TH} = \frac{R_{B2}}{R_{B1} + R_{B2}} V_{CC}, \text{ applying the VDR across two-resistor network.}$$

$$R_{TH} = \frac{R_{B1} R_{B2}}{R_{B1} + R_{B2}}, \text{ shorting the voltage source, } V_{CC} \text{ at the base terminal.}$$

The DC analysis of the circuit is simple by applying KVL at the input and the output loops of Fig. 1 (b). Applying KVL in the input loop of Fig. 1 (b).

$$\begin{aligned} V_{TH} &= I_B R_{TH} + V_{BE} + I_E R_E = I_B R_{TH} + V_{BE} + (I_B + I_C) R_E \\ \Rightarrow V_{TH} &= I_B R_{TH} + V_{BE} + (I_B + \beta I_B) R_E = I_B \{R_{TH} + (1 + \beta) R_E\} + V_{BE} \\ \Rightarrow I_B &= \frac{V_{TH} - V_{BE}}{R_{TH} + (1 + \beta) R_E} \end{aligned}$$

Applying KVL in the output loop of Fig. 1 (b).

$$\begin{aligned} V_{CC} &= I_C R_C + V_{CE} + I_E R_E = I_C R_C + V_{CE} + (I_B + I_C) R_E \\ \Rightarrow V_{CC} &= I_C R_C + V_{CE} + I_C R_E; \quad I_C \gg I_B \\ \Rightarrow I_C &= \frac{V_{CC} - V_{CE}}{R_C + R_E} \end{aligned}$$

So, the quiescent point collector and emitter currents as well as collector-to-emitter voltage can be written as-

$$\begin{aligned} I_{CQ} &= \beta I_B \\ I_{EQ} &= (1 + \beta) I_B \\ V_{CEQ} &= V_{CC} - I_{CQ} R_C - I_{EQ} R_E \end{aligned}$$

If the BJT is in the active mode, the following typical values can be observed-

$$V_{BE} = 0.7 \text{ V and } I_C = \beta I_B$$

The collector resistance,  $R_C$  is used to adjust the collector voltage,  $V_C$ . Finally, the emitter resistance,  $R_E$  is used to stabilize the DC biasing point (operating point or quiescent point or  $Q$ -point). Using the above equations, the stability of biasing points for different transistors of  $\beta$  can be calculated.

**Note:** It is a good idea to set the bias for a single stage amplifier to half the supply voltage, as this allows maximum output voltage swing in both directions of an output waveform. For maximum symmetrical swing, it is clear from the figure that the collector-to-emitter voltage,  $V_{CE}$  should be equal to the half of the collector supply voltage,  $V_{CC}$  that is,  $V_{CE} = V_{CC}/2$ .

### Circuit Configuration:

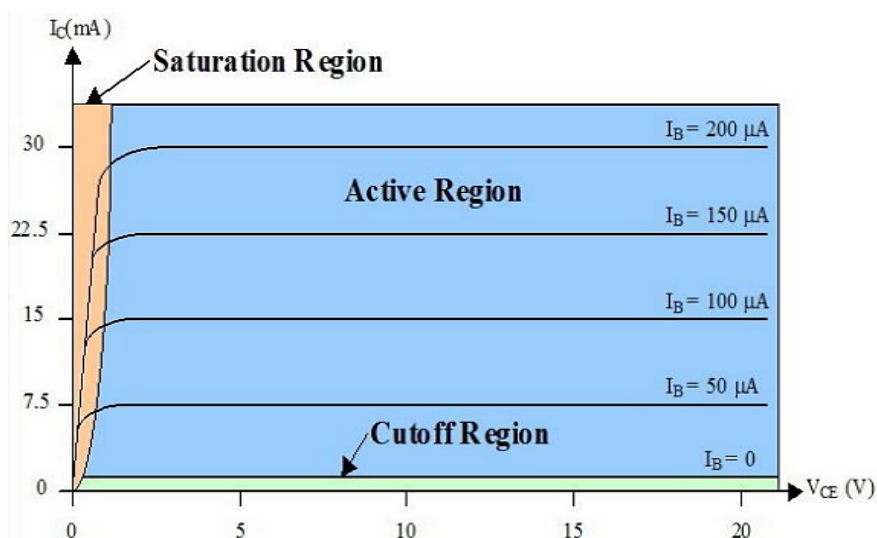
The **common emitter configuration** is used for voltage and current amplification and is the most common configuration for transistor amplifiers. In this configuration, the emitter terminal is common between the input (base) and collector (output) terminals of the transistor.

### Biasing of Bipolar Junction Transistors:

**Active Mode:** The emitter junction is forward-biased, and the collector junction is reverse-biased. If the BJT is operated in active mode, then the BJT can be used as an amplifier.

### Output Characteristics:

The output characteristics curves for a common emitter configured BJT are plotted between the collector current,  $I_C$ , and the collector-to-emitter voltage drop by keeping the base current,  $I_B$  constant as shown in Fig. 2. These curves are almost horizontal. The output dynamic resistance again can be calculated from the ratio of the small change of emitter-to-collector voltage drop to the small change of the collector current.



**Figure 2:** BJT Common Emitter Output Characteristics.

### Pre-Lab Homework:

Students will be provided with the upcoming lab manuals, and they will be asked to prepare the theoretical (operations/working principle) information on the topic from the textbook.

Besides, they must implement the circuit (as given in Figure 3) using a MultiSIM simulator. Observe the base and collector currents as well as collector to emitter voltage through simulations ( $I_B$ ,  $I_C$ ,  $V_B$ ,  $V_C$ ,  $V_E$ , and  $V_{CE}$ ) and take snapshots using the snipping tool. Measure the values of different key parameters and fill up the table (Table 1) based on the simulation results. For simulation, use a 2N2222, or a C828, or BD135 transistor.

Perform a transient analysis of a sinusoidal input signal. The input signal,  $V_s$  exhibits a frequency of 1 kHz and an amplitude 10 mV peak. Display the input voltage and the voltage across load resistance  $R_L$  together to see the transistor amplification characteristics. Also, display the base voltage,  $V_B$ .

### Apparatus:

SL#	Apparatus	Quantity
1	BJT (2N2222, C828, BD135)	1 each
2	Resistance ( $R_{B,POT} = 0-500 \text{ k}\Omega$ , $R_{L,POT} = 0-100 \text{ k}\Omega$ , $R_C = 470 \text{ }\Omega$ , $R_E = 560 \text{ }\Omega$ , $R = 33 \text{ k}\Omega$ , $R_{B2} = 3.3 \text{ k}\Omega$ )	1 each
3	Capacitor (10 $\mu\text{F}$ and 100 $\mu\text{F}$ )	2 + 1
4	Project Board	1
5	Signal Generator and DC Power Supply	1 + 1
6	Oscilloscope and Probes	1 + 2
7	DC milliammeter (0-50 mA)	1
8	DC microammeter (0-500 $\mu\text{A}$ )	1
9	Multimeter	1
10	Connecting Leads	10

### Precaution!

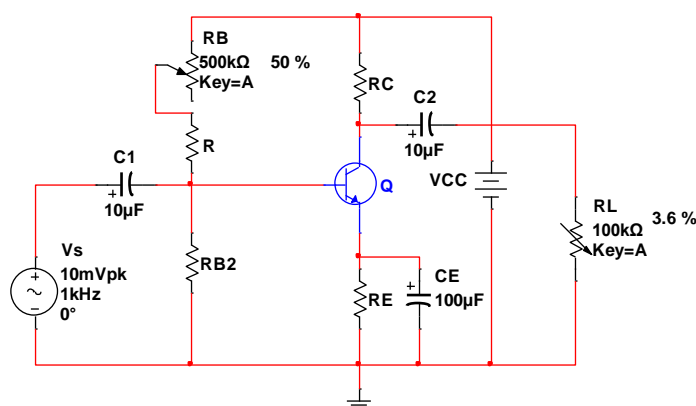
The following is a list of some of the special safety precautions that should be taken into consideration when working with transistors:

1. Never remove or insert a transistor into a circuit with voltage applied.
2. Ensure a replacement transistor into a circuit is in the correct direction.

3. Transistors are sensitive to being damaged by electrical overloads, heat, humidity, and radiation. Damage of this nature often occurs by applying the incorrect polarity voltage to the collector circuit or excessive voltage to the input circuit.
4. One of the most frequent causes of damage to a transistor is the electrostatic discharge from the human body when the device is handled.
5. The applied voltage and current should not exceed the maximum rating of the given transistor.
6. Change the components or any of their properties by turning off the power/stopping the simulation.

### Experimental Procedures:

1. Measure the actual values of the base, emitter, and collector resistors.
2. Identify the terminals of the transistor and measure the value of Beta ( $\beta$ ).
3. Connect the circuit and connect the microammeter and milliammeter as shown in Fig. 3.
4. Connect the multimeter (voltmeter mode) to measure the base resistance voltage ( $V_B$ ) and input voltage ( $V_{BE}$ ).
5. Turn on both the DC power supply with the voltage control nob at 0 V and then set the collector supply voltage,  $V_{CC}$  to 15 V.
6. Now, adjust the 500 k $\Omega$  potentiometer until the collector-to-emitter voltage,  $V_{CE}$  is approximately equal to the half of the collector supply voltage,  $V_{CC}$  that is,  $V_{CE} = V_{CC}/2$ .
7. Measure collector-to-emitter voltage,  $V_{CE}$ , base-to-emitter voltage,  $V_{BE}$ , base current,  $I_B$ , emitter current,  $I_E$ , and collector current,  $I_C$ . Calculate the based current,  $I_B$  from the collector current,  $I_C$  using the value of  $\beta$ . Record the measured values in Table 1.
8. Now, feed a sinusoidal AC signal of 1 kHz at the input with 10 mV peak value as shown in Fig. 3.
9. Observe the input and output signals on the oscilloscope screen in DUAL mode.
10. Increase the input signal till the output wave shape starts getting distorted. Measure this input signal. This is the maximum input signal that the amplifier can amplify without any distortion.
11. Now feed an AC signal that is less than the maximum signal handling capacity of the amplifier. Fix the input signal frequency at 1 kHz, Draw the input and output voltage wave shape, and calculate the voltage gain,  $A_V$ .
12. Connect a potentiometer (0-100 k $\Omega$ ) as the load resistor, vary the potentiometer knob, and measure the output voltages for each case. Record them in Table 2. Also, find the voltage gain,  $A_V$  of the amplifier for each case.
13. Compute the voltage gain,  $A_V$  of the amplifier circuit for each case in decibels ( $A_{V,dB} = 20 \log_{10} A_V$ ).
14. Record the images of the hardware and simulation circuit diagrams as well as various wave shapes.
15. Turn off the DC power supply, function generator, and oscilloscope.



**Figure 3:** Circuit diagram for the study of CE BJT amplifier circuit

**Table 1** Measured data of the voltage divider bias circuit, operating point, and transistor parameter

$V_{CC}$	$\beta$	$V_{CE}$	$V_{BE}$	$I_B$	$I_C$	$I_E$

**Table 2 Measured data of the voltage gain of the amplifier circuit against the load resistances.**

Load Resistor, $R_L$ (k $\Omega$ )	Input voltage, $V_i$ (mV)	Output Voltage, $V_o$ (V)	Gain, $A_v = \frac{V_{out}}{V_{in}}$	Gain in dB $A_{v,dB} = 20\log_{10} A_v$
1				
3.3				
4.7				
5.6				
8.2				
10				
20				
33				
47				
75				
90				
100				

**Questions:**

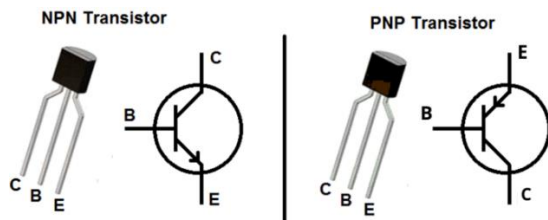
1. Show the difference between your simulated and measured values. Comment on the results and interpret the experimental and simulation data.
2. From the obtained data, draw the load characteristic curve of the voltage gain in dB ( $A_{v,dB}$ ) vs. the load resistance ( $R_L$ ) for a BJT common emitter (CE) amplifier circuit.
3. Explain the behavior of the CE amplifier circuit in the active, saturation, and cut-off regions of operation.
4. Determine the BJT parameters from the data sheet. Compare it with the experimental values.
5. Why biasing is necessary for BJT amplifier circuit?
6. Why do we need all the capacitors and resistors shown in the circuit? Explain with necessary equations.
7. Give your suggestions regarding this experiment.
8. Discuss the overall aspects of the experiment. Did your results match the expected ones? If not, explain.

**References:**

- [1] Robert L. Boylestad, Louis Nashelsky, Electronic Devices and Circuit Theory, 9<sup>th</sup> Edition, 2007-2008
- [2] Adel S. Sedra, Kenneth C. Smith, Microelectronic Circuits, Saunders College Publishing, 3rd ed., ISBN: 0-03-051648-X, 1991.
- [3] American International University–Bangladesh (AIUB) Electronic Devices Lab Manual.
- [4] David J. Comer, Donald T. Comer, Fundamentals of Electronic Circuit Design, John Wiley & Sons Canada, Ltd., ISBN: 0471410160, 2002.
- [5] J. Keown, ORCAD PSpice and Circuit Analysis, Prentice Hall Press (2001)
- [6] Resistor values: <https://www.eleccircuit.com/how-to-basic-use-resistor/>, accessed on 20 September 2023.

List the references that you have used to answer the “Discussion” section.

## Appendix A: Identifying the terminals of an npn or a pnp transistor:



Following are the steps to identify npn and pnp transistors:

Step 1: Take the transistor you want to identify.

Step 2: Turn on a digital multimeter and set it to the DC voltage/resistance measurement mode.

Step 3: Make sure that you have connected the probes in their correct respective multimeter sockets, i.e., the black probe to the COM port and the red probe to the V/ $\Omega$ / port.

Step 4: Randomly start connecting the multimeter probes to the terminal of an unknown type of transistor and watch readings on the screen.

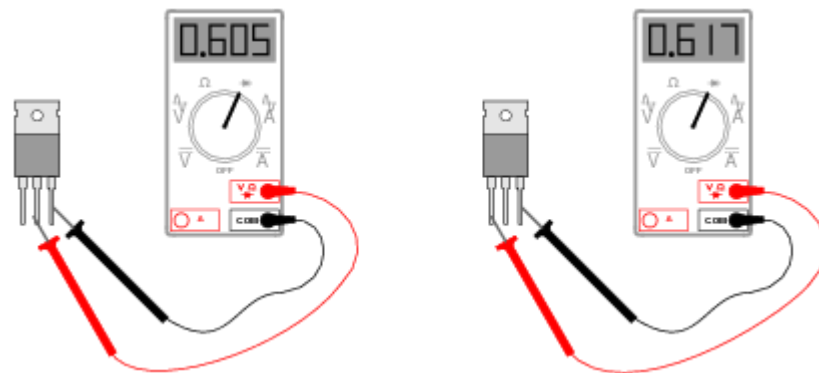
Step 5: Now, some random connections will give you a voltage/resistance reading on the multimeter screen.

Step 6: Once you get results i.e., any values (must be less than 1 for voltage reading) on the screen, start from the right side with the transistor's flat side upward direction, and write or mark the probes attached to the terminals of the transistor.

Step 7: If it is a black probe first and a red probe second then transfer the black probe to the third terminal (left-most terminal). If you get a similar result on the screen then write n, p, and n, that is the transistor is of npn type.

Step 8: If it is a red probe first and then a black probe second then transfer the red probe to the third terminal (left-most terminal). If you get a similar result on the screen then write p, n, and p, that is the transistor is of pnp type.

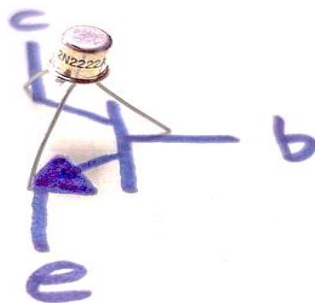
Step 9: The values you get on the multimeter screen after and before transferring the probe from the right-most side to the left-most side will differ slightly, the higher value-giving terminal is called the emitter and the lower value-giving terminal is called the collector, and the common terminal in the middle is called the base.



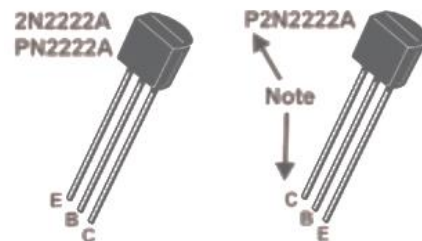
Based on the above procedural steps using a multimeter in diode mode, the left terminal of this transistor is a p-type emitter (producing larger value), the middle one is a p-type collector (less value), and the right one is called a base (common black terminal, so n-type). As such, this is a pnp-type transistor.

## Appendix B: The 2N2222 Data Sheet

The 2N2222 is a common NPN bipolar junction transistor (BJT) used for general-purpose low-power amplifying or switching applications. It is designed for low to medium current, low power, medium voltage, and can operate at moderately high speeds. It was originally made in the TO-18 metal can as shown in the picture.



2N2222A in metal TO-18 package with the emitter, base and collector identified as E, B, and C respectively.



Pinout of 2N2222 variants in plastic TO-92 package.



2N2222A in metal TO-18 package with the emitter, base and collector identified as E, B, and C respectively.

Philips Semiconductors

Product specification

## NPN switching transistors

## 2N2222; 2N2222A

### FEATURES

- High current (max. 800 mA)
- Low voltage (max. 40 V).

### APPLICATIONS

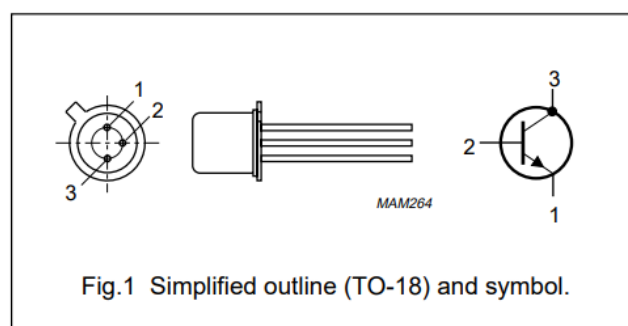
- Linear amplification and switching.

### DESCRIPTION

NPN switching transistor in a TO-18 metal package.  
PNP complement: 2N2907A.

### PINNING

PIN	DESCRIPTION
1	emitter
2	base
3	collector, connected to case



### QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CBO}$	collector-base voltage	open emitter	–	60	V
	2N2222 2N2222A		–	75	V
$V_{CEO}$	collector-emitter voltage	open base	–	30	V
	2N2222 2N2222A		–	40	V
$I_C$	collector current (DC)		–	800	mA
$P_{tot}$	total power dissipation	$T_{amb} \leq 25\text{ }^{\circ}\text{C}$	–	500	mW
$h_{FE}$	DC current gain	$I_C = 10\text{ mA}; V_{CE} = 10\text{ V}$	75	–	
$f_T$	transition frequency	$I_C = 20\text{ mA}; V_{CE} = 20\text{ V}; f = 100\text{ MHz}$	250	–	MHz
	2N2222 2N2222A		300	–	MHz
$t_{off}$	turn-off time	$I_{Con} = 150\text{ mA}; I_{Bon} = 15\text{ mA}; I_{Boff} = -15\text{ mA}$	–	250	ns



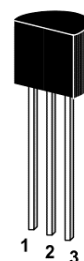
**LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CBO}$	collector-base voltage 2N2222 2N2222A	open emitter	–	60	V
			–	75	V
$V_{CEO}$	collector-emitter voltage 2N2222 2N2222A	open base	–	30	V
			–	40	V
$V_{EBO}$	emitter-base voltage 2N2222 2N2222A	open collector	–	5	V
			–	6	V
$I_C$	collector current (DC)		–	800	mA
$I_{CM}$	peak collector current		–	800	mA
$I_{BM}$	peak base current		–	200	mA
$P_{tot}$	total power dissipation	$T_{amb} \leq 25\text{ }^{\circ}\text{C}$	–	500	mW
		$T_{case} \leq 25\text{ }^{\circ}\text{C}$	–	1.2	W
$T_{stg}$	storage temperature		–65	+150	$^{\circ}\text{C}$
$T_j$	junction temperature		–	200	$^{\circ}\text{C}$
$T_{amb}$	operating ambient temperature		–65	+150	$^{\circ}\text{C}$

**Appendix C: The C828 Data Sheet**

ST 2SC828 / 828A is an NPN Silicon Epitaxial Planar Transistor for switching and AF amplifier applications. These transistors are subdivided into three groups Q, R and S according to their DC current gain. On special request, these transistors can be manufactured in different pin configurations. TO-92 Plastic Package Weight approx. 0.19 gm.



1. Emitter 2. Collector 3. Base

Pin configuration of TO-92 Plastic Package.

Absolute Maximum Ratings ( $T_a = 25^{\circ}\text{C}$ )

	Symbol	Value		Unit
		ST 2SC828	ST 2SC828A	
Collector Base Voltage	$V_{CBO}$	30	45	V
Collector Emitter Voltage	$V_{CEO}$	25	45	V
Emitter Base Voltage	$V_{EBO}$	7		V
Peak Collector Current	$I_{CM}$	100		mA
Collector Current	$I_C$	50		mA
Power Dissipation	$P_{tot}$	400		mW
Junction Temperature	$T_j$	150		$^{\circ}\text{C}$
Storage Temperature Range	$T_S$	-55 to +150		$^{\circ}\text{C}$

**Characteristics at  $T_{amb}=25^{\circ}\text{C}$** 

	Symbol	Min.	Typ.	Max.	Unit
DC Current Gain at $I_C=2\text{mA}$ , $V_{CE}=5\text{V}$					
Current Gain Group Q	$h_{FE}$	130	-	280	-
R	$h_{FE}$	180	-	360	-
S	$h_{FE}$	260	-	520	-
Collector Base Breakdown Voltage at $I_C=10\mu\text{A}$					
ST 2SC828	$V_{(BR)CBO}$	30	-	-	V
ST 2SC828A	$V_{(BR)CBO}$	45	-	-	V
Collector Emitter Breakdown Voltage at $I_C=2\text{mA}$					
ST 2SC828	$V_{(BR)CEO}$	25	-	-	V
ST 2SC828A	$V_{(BR)CEO}$	45	-	-	V
Emitter Base Breakdown Voltage at $I_E=10\mu\text{A}$	$V_{(BR)EBO}$	7	-	-	V
Collector Saturation Voltage at $I_C=50\text{mA}$ , $I_B=5\text{mA}$	$V_{CE(sat)}$	-	0.14	-	V
Base Emitter Voltage at $I_C=10\text{mA}$ , $V_{CE}=5\text{V}$	$V_{BE}$	-	-	0.8	V
Gain Bandwidth Product at $I_C=2\text{mA}$ , $V_{CE}=10\text{V}$	$f_T$	-	220	-	MHz
Noise Figure at $V_{CE}=5\text{V}$ , $I_E=0.2\text{mA}$ , $R_G=2\text{k}\Omega$ , $f=1\text{kHz}$	NF	-	6	-	dB